

Europäisches Patentamt European Patent Office



EP 1 279 964 A1

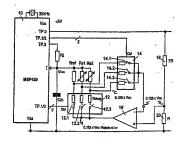
(12)

EUROPEAN PATENT APPLICATION

- (43) Date of publication: 29.01.2003 Bulletin 2003/05
- (51) Int CL7: G01R 27/02
- (21) Application number: 02015590.9
- (22) Date of filing: 15.07.2002
- (84) Designated Contracting States: AT BE BG CH CY CZ DE DK EE ES FI FR GB GR IE IT LI LU MC NL PT SE SK TR Designated Extension States: AL LT LV MK RO SI
- (72) Inventor: Bierl, Lutz 85435 Erding (DE)
- (30) Priority: 17.07.2001 DE 10134635
- (71) Applicant: TEXAS INSTRUMENTS DEUTSCHLAND GMBH 85356 Freising (DE)
- (74) Representative: Degwert, Hartmut, Dipl.-Phys. Prinz & Partner GbR. Manzingerweg 7 81241 München (DE)

Resistance measuring circuit (54)

In the resistance measuring circuit a measuring capacitor (Cm), as controlled by a microcomputer (10). is charged in a first cycle to a predefined charging voltage (Vcc) and discharged via a reference resistor (Bref) to a predefined discharge voltage before then being recharged in a second cycle to the charging voltage and discharged via the resistance to be measured (Rs1) to the discharge voltage. The microcomputer (10) measures in each cycle the time duration between the start of the discharge procedure and the point in time of attaining a predefined fixed value of the voltage between the charging voltage and the discharge voltage across the measuring capacitor (Cm). From the product of the reference resistance and the ratio of the time duration measured in the second and first cycle the resistance value to be measured is determined. There is provided a closed loop (10, 14, 16) for controlling the discharge voltage to a fixed predefined constant value.



Fia.2

[0001] The invention relates to a resistance measuring circuit including a measuring capacitor which, as controlled by a microcomputer, is charged in a first cycle to a predefined charging voltage and discharged via a reference resistor to a predefined discharge voltage before then being recharged in a second cycle to the charging voltage and discharged via the resistance to be measured to the discharge voltage, the microcomputer measuring in each cycle the time duration between the start of the discharge procedure and the point in time of attaining a predefined fixed value of the voltage between the charging voltage and the discharge voltage across the measuring capacitor and determining from the product of the reference resistance and the ratio of the time duration measured in the second and first cycle the resistance value to be measured [0002] In actual practice it is often necessary to measure the value of a resistance to determine a physical pa- 20 rameter which influences the value of the resistance. For temperature measuring, use is made typically of resistances whose value are a function of the temperature existing at the time. This is why to determine the temperature first a resistance value needs to be measured 25 and the actual desired parameter, namely the temperature can then be determined from the measured value. A resistance measuring circuit of the aforementioned kind is described, for example, on page 2-186 of TEXAS INSTRUMENTS "MSP430 Family Application Reports 30 2000" (SLAA024), the basic circuit of which for this measuring is shown in Fig. 1. The complete measuring procedure is controlled by a microcomputer 10 which may be a TEXAS INSTRUMENTS type MSP430 microcomputer. The measuring circuit contains a measuring 35 capacitor Cm which can be charged via a charging resistor R1 to the supply voltage Vcc of the microcomputer 10. For this charging procedure the microcomputer 10 outputs at its terminal TP.3 the supply voltage Vcc whilst switching its terminals TP.0, TP.1 and TP.2 to a high impedance state. This results in a charging circuit which leads to ground Vss via the charging resistor R1 and the measuring capacitor Cm. As soon as the measuring capacitor Cm has been charged to the supply voltage Vcc the microcomputer 10 switches the terminal TP.3 to a 45 high impedance state whilst connecting the terminal TP. 2 to ground Vss. This results in the measuring capacitor Cm being discharged to ground via the reference resistor Rref. On commencement of the discharge procedure the microcomputer 10 starts a count which increments 50 until the charging voltage of the measuring capacitor Cm at the input I 27 of the microcomputer 10 drops below a predefined threshold value. The count attained at this point in time is a measure of the time taken from the start

of discharge to attaining the threshold value. Subse-

quent to this first discharge procedure, the measuring

capacitor Cm is recharged to the supply voltage Vcc,

resulting in the measuring capacitor grounding the ter-

minal TP, so that the measuring capacitor Cm is discharged with measuring resistor Rs1. The same as before, the time duration from the start of the discharge procedure up to attaining the threshold value is determined from the count. If, in addition, the value of the measuring relator Rs2 is no be determined, and charging and discharge cycle is implemented as desithed.

[0003] From the times measured and the value of the reference resistor Rref the value of the measuring resistor Rs1 and correspondingly also, where necessary, the value of the measuring resistor Rs2 can be determined from the formula

$$Rs1 = Rref \times \frac{tRs_1}{t_{mf}}$$

[0004] How the necessary potentials are applied to the corresponding TP terminals in the microcomputer 10 relative to the terminal TP.0 thereof is evident from Fig. 1. In this arrangement, the necessary switches of the microcomputer 10 are formed by MOS transistors which have a relatively high resistance value in the ON condition which is usually termed the internal resistance Rdson. This internal resistance located in each case in the discharge cycle of the measuring capacitor Cm influences the measuring accuracy achievable with the measuring capacitor as shown in Fig. 1. It is particularly in applications demanding extremely high accuracy, for example in calorimeter temperature measurement, that the temperature-dependent synchronism error of each internal resistance has serious consequences. The discharge curve of the measuring capacitor Cm falls name. ly asymptotically to a value which is influenced by the internal resistance of the MOS transfor located in the discharge circuit at the time. The temperature-dependent synchronism errors of these Internal resistances make it impossible to measure the resistance without additional complicated circultry when yery high accura-

[0005] The Invantion is thus based on the objective of providing a resistance measuring circuit of the aforementioned kind with the aid of which a very high measuring accuracy is achievable which is not influenced by the internal resistances of the analog switches used in

cv is mandatory.

controlling the discharge procedure.

[0008] To achieve this objective there is provided in the resistance measuring circuit a closed loop for regulating the discharge voltage to a fixed predefined constent value.

[0007] By maintaining the discharge voltage constant with the aid of the closed loop it is achieved that the measuring capacitor Cm discharges to a discharge voltage value which is not influenced by the internal resista

ance of a switch located in the discharge circuit. This results in the time needed to discharge the reference resistor and the resistance to be measured being exclusively a function of their resistance values so that the desired high accuracy is achievable.

[0008] Advantageous further embodiments of the invention are characterized in the subclaims.

[0009] Example embodiments of the invention will now be detailed with reference to the drawing in which:

- Fig. 1 is a block diagram of a prior art resistance measuring circuit,
- Fig. 2 is a block diagram of a resistance measuring circuit in accordance witth a first embodiment of the invention,
- Fig. 3 is a graph helping to explain how the resistance measuring circuit as shown in Fig. 2 works, and
- Fig. 4 is a block diagram of a resistance measuring circuit in accordance witth a second embodiment of the invention.

[0010] Referring now to Fig. 2 there is illustrated the resistance measuring circuit comprising a microcomputer 10 of the type MSP430. The microcomputer 10 are 10 of the type MSP430. The microcomputer 10 are ceives a supply voltage Vcc of +5 V relative to ground Vss. It comprises terminals 17 for outputting control eignals having the value of the supply voltage Vcc or of the ground Vss. These outputs are so-called tristate outputs which in addition to the states in which they can output the clied control signals, they may also assume a high impedance state. Furthermore, the microcomputer 10 comprises an input 1 via which it is able to analyze a voltage applied thereto. The input is the input of a comparator whose task it is to setablish whether the voltage supplied to it is above or below a defined threshold val-

[0011] The resistance measuring circuit contains further two arrays of analog switches 12, 14 each comprising three switches 12, 1, 122, 12.3 and 14, 1, 14.2, 14.3 respectively in the form of MoS translators. Assigned to the switches are resistances to illustrate that the MOS translators forming the switches also include an internal resistance in the ON state, usually termed Rison. [0012] Located between the input I and ground is a

[0012] Located between the input I and ground is a dreasuring capecitor Cm which can be charged via a resistor R1 located between the terminal TP3 and the input I. Furthermore connected to the input I is a released resistor. Ref and two resistances Rsf and Rs2 to be measured. In the example application, these two resistors are NTC resistors so that by establishing the resistance values of the two resistors by application of suitable algorithms in the microcomputer 10 the temperatures at the sits of each resistance to be measured can be determined.

[0013] As evident, the resistances Rref, Rs1 and Rs2 are connected via the switches of the analog switch array 12 to the outputs of a differential amplifier and via

the switches of the analog switch array 14 to the invering input of a differential amplifier 16. The non-inverting input of this differential amplifier 16 receives a fixed voliage formed by a voltage divider made up of two realstore 18 and 20. The values of the resistors 18 and 20 relate in the ratio 7:1 so that a voltage materializes across the

In the ratio 7:1 so that a voltage materializes across the non-inverting input of the differential amplifier 16 which amounts to 0.125 y Voc

amounts to 0.125 x Vcc.

[0014] The analog switch arrays 12 and 14 can be controlled with the old of the control signals output by

controlled with the ald of the control signals output by the microcomputer 10 so that the switches 12.1, 12.2, 12.4 and 14.1, 14.2, 14.3 respectively can be opened or closed as required, only the switches assigned to the same resistor Rivel, Rs1 or Rs2 being simultaneously 5 closed each time with each switch array.

[0015] The sequence in the measuring procedure as implemented with the aid of the resistance measuring circuit as shown in Fig. 2 is as follows:

[0016] The microcomputer 10 outputs during the comlow plete measuring procedure at its terminal TP.0 the supply voltage Voc so that the aforementioned voltage of
0.125 x Voc is permanently applied to the non-inverting
input of the differential amplifier 16. On commencement
of the actual measuring procedure the microcomputer

5 10 opens all switches of the analog switch arrays 12 and 14 by outputting corresponding control signals, and it outputs at terminal TP3 the supply voltage Vcc, resulting in the measuring capacitor Cm being charged via the resistor R1 to the supply voltage Vcc.

plot as shown in Fig. 3.

[0018] Once the measuring capacitor Cm has been fully charged the microcomputer 10 signals the terminal TP.3 HI whilst closing the switch 12.1 or 14.1 assigned to the reference resistor Rref in the analog switch arrays

12 and 14 respective by corresponding control signals. This permits sideshage of the measuring capacitor with the reference resistor firef and the closed switch 12.1 to the voltage which is applied from the outputs of 40 the differential amplillar 16 to the terminal of the reference resistor Ref connected to the sexth 12.1 of the analog switch array 12. The differential amplifier 16 fed back via the closed switches in the analog switch array 12, 14 has the property of bringing the voltage at its in-

14. I has the ployery of bringing the volsage at usinverting input to the same value as applied to the noninverting input by outputting a corresponding outputs voltage. So that the differential amplifier 16 is able to produce at its inverting input the same voltage as at its non-inverting input it heads to output a voltage as the lower than 0.125 x Voc; it being lower by the drop in voltage across the internal resistance Riscon of the closed switch 12.1 resulting from the discharge current ired or the measuring capacitic Cm flowing via the referance resistor Firef, if a. a closed sloop exists which en-

sures that the voltage to which the measuring capacitor Cm discharges is always maintained constant at the value 0.125 x Vcc.

[0019] Because of this closed loop the internal resist-

ance Rdson of the closed switch in the analog switch array 12 no longer influences the voltage value to which the measuring capacitor Cm is discharged. The slope of the discharge curve is thus solely dictated by the value of the measuring capacitor Cm and the value of the reference resistor Ref.

[0020] Referring now to Fig. 3 there is illustrated the plot of the discharge curve indicating how the discharge begins across the voltage value supply voltage Vcc and drops asymptotically to the value Vg corresponding to 0.125 x Vcc.

[0021] On commencement of the discharge procedure a counter is started in the microcomputer 10, the count of which is clock incremented until the votage across the measuring capacitor Cm and thus the voltage at the input i of the microcomputer 10 has attained at the input in of the microcomputer 10 has attained pratter internally connected to the input of the value Vt, this designating the threshold value of the comparator internally connected to the input i. As evident from Fig. 3 this is attained on the most of time duration tred at which the counter is haited so that the attained count is a measure of the time duration tref.

[0022] Following this discharge procedure the measuring capacitor Cm is recharged to the supply voltage Voc by the microcomputer 10, as evident from Fig. 3. During this charging procedure all switches in the analogs witch array 12 and 14 are opened and charging is done the same as before wit the resistor F1.

[0023] A new discharge procedure then follows in which, nowever, the ewithchs 12 or 14.2 are closed in the analog switch array 12 and 14 respectively. This so means that the measuring capacitor Cm discharges via the resistor Fs1, here again due to the closed loop the constant voltage 0.125 x Vco is set at the terminal of the resistor Fs1 connected to the switch 12.2.

[0024] The time duration ts (Fig. 3) between commencement of the discharge procedure and the threshold voltage Vt being attained at input I is again recorded in the form of a count.

[0025] In allkawise proceeding third charging and discharge procedure a third further time duration (not 40 shown in Fig. 3) can be determined in which discharge of the measuring capacitor Cm via the resistor Rs2 occurs

[0026] The value of the resistor Rs1 is established by way of corresponding algorithms in the microcomputer 10 in making use of the formulae as given in the following:

[0027] The formula for the time duration tref is

$$tref = \left[-\ln \frac{V_t}{V_{cc}} \right] \times Cm \times Rref$$

[0028] The formula for the time duration to is

$$ts = \left[-\ln \frac{V_t}{V_{CC}}\right] \times Cm \times Rs1$$

[0029] The resistance value of the resistor Rs1 then being:

$$Rs1 = Rref \times \frac{ts}{tss}$$

[0030] It is to be noted that the internal resistances of the switches in the analog switch array 14 are irrelevant to the measurement, since no current flows via these internal resistances in any phase of the measuring procedure, there thus being not drop in voltage across these resistances capable of Influencing the result of the penasuring procedure.

19031 In the circuit as shown in Fig. 2 it is thus assured, by introducing the constant closed loop control of the voltage to which the measuring capacitor. On it discharged, that the internal resistances of sech of the switches formed by MOS translators involved have no effect on the measuring result. This now permits exhibiting a very high accuracy in establishing the wanted resistances vitue as in screezary, for extrainly when temperatures needs to be measured in calcrimeters in maximum and the control of the resistances vitue as in screezary, for extrainly when temperatures needs to be measured in calcrimeters in maximum and the control of the resistance vitue as highly accurate measurement requires a highly accurate measurement requires a highly accurate measurement requires and produced of the resistance of the resistance

[0032] Releming now to Fig. 4 there is illustrated a further embodiment of the resistance measuring circuit in accordance with the invention. In this embodiment a separate differential ampillier (5.1, 16.2, 16.3 is providdof or each resistance to be measured and for the relerance resistor so that now only one array of analog witches is needed between the outputs of the differential ampilliers and the resistors. This embodiment has better cost-effectiveness when taking into account that arrays of analog witches in the form of integrated ofcuts are more complicated and expensive than Integratact circuits containing several differential ampilliers.

49 [0033] The procedure in measuring the resistance values is the same as explained with reference 16; 2, it likewise being attained in this embodiment that the voltage value to which the measuring capacitor in discharged is regulated by the closed loop to the constant value of 125 x Voc so that the internal resistances of the switches of the analog switch array 12 cannot faisfly the result of the measurement.

55 Claims

 A resistance measuring circuit including a measuring capacitor which, as controlled by a microcomputer, is charged in a first cycle to a predefined charging voltage and discharged via a reference resistor to a predefined discharge voltage before then being recharged in a second cycle to the charging voltage and discharged via the resistance to be measured to the discharge voltage, the microcomputer measuring in each cycle the time duration between the start of the discharge procedure and the point in time of attaining a predefined fixed value of the voltage between the charging voltage and the 10 discharge voltage across the measuring capacitor and determining from the product of the reference resistance and the ratio of the time duration measured in the second and first cycle the resistance value to be measured, characterized in that a closed 15 loop (12, 14, 16; 12, 16.1, 16.2, 16.3) for controlling said discharge voltage to a fixed predefined constant value is provided.

(Rs1, Rs2) are provided whose resistance values are a function of the temperature so that from said measured resistance values the temperature values needed forcalculating the calorific value can be determined.

- 2. The resistance measuring circuit as set forth in 20 claim 1, characterized in that said analog switches (12.1, 12.2, 12.4 or 14.1, 14.2, 14.3) formed by MOS transistors are provided, which as controlled by signals from said microcomputer (10) open or close said discharge circuits for said measuring ca- 25 pacitor Cm in the corresponding cycles and in that said closed loop contains a differential amplifier (16) including a non-inverting input and an inverting input, said non-inverting input receiving said discharge voltage, said inverting input being connect- 30 able via an analog switch to a terminal of said reference resistor Rref or to said resistance (Rs1, Rs2) to be measured and the output of which is connectable via a analog switch to the one terminal of said reference resistor or said resistance to be meas- 35
- 3. The resistance measuring circuit as set forth in claim 1, characterized in that said analog switches (12.1, 12.2, 12.3) formed by MOS transistors are 40 provided, which as controlled by signals from said microcomputer (10) open or close said discharge circuits for said measuring capacitor (Cm) in the corresponding cycles and in that in said closed loop, a differential amplifier (16.1, 16.2, 16.3) in- 45 cluding a non-inverting input and an inverting input is assigned each to said reference resistor (Rref) and said resistance to be measured, said non-inverting inputs receiving said discharge voltage, said inverting inputs being connectable via an analog 50 switch to a terminal of said assigned resistor, and the outputs of which are each connectable via an analog switch to said terminal of said assigned re-
- Use of said resistance measuring circuit as set forth in any of the preceding claims in a calorimeter, characterized in that two measuring resistors

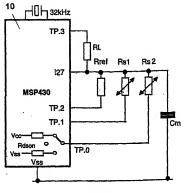


Fig.1

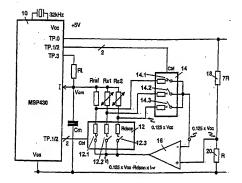


Fig.2

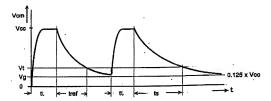


Fig.3

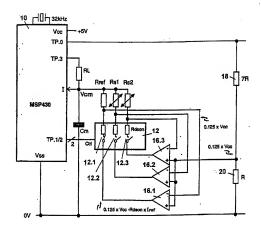


Fig.4



European Patent Office

EUROPEAN SEARCH REPORT

Application Number EP 02 01 5590

Category	Citation of document with indica of relevant passages	tion, where appropriate,	Relevant to claim	CLASSIFICATION OF THE APPLICATION (Int.CI.7)
А	GB 2 267 967 A (STATUS 22 December 1993 (1993 * claim 1 *	INSTR LIMITED) 1-12-22)	-4	G01R27/02
				YECHNICAL PIELDS SEARCHED (M.C.:7 GO1R
	The present search report has been			
Place of assists THE HAGUE		28 November 2002	Vyt	Donnor Clacilová, L
X : part Y : part door A : tech	ATEGORY OF CITED DOCUMENTS ficularly relevant if taken alone licularly relevant if combined with another uman of the same category herological bickground	T: theory or polociple un G: earlier petent clocum after the filing date D: document cited in th L: document cited for or	derlying the ent, but pub- e application ther mesons	Envention Bished on, or

EP 1 279 964 A1

ANNEX TO THE EUROPEAN SEARCH REPORT ON EUROPEAN PATENT APPLICATION NO.

EP 02 01 5590

This annex lists the patent family members relating to the patent documents closd in the above-mentioned European search report. The members are as contained in the European Patent Office EDP (8) on The European Patent Office is in no way lable to These particulars which are merely given for the purpose of information.

28-11-2002

Patent document rited in search report		Publication date		Patent family member(s)	Publication date
GB 2267967	A	22-12-1993	NONE		
		e Official Journal of the			